Se	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/894,862	LEE ET AL.	
Examiner	Art Unit	
Thai Q. Phan	2128	

	SEARCHED			
Class	Subclass	Date	Examiner	
703	2	6/26/2005	T.P	
703	7	6/26/2005	T.P.	
703	9	6/26/2005	T.P	
716	5	6/26/2005	T.P.	
716	11	6/26/2005	T.P.	
422	96	6/26/2005	T.P.	
422	98	6/26/2005	T.P.	
707	102	6/26/2005	T.P.	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
703	2	6/26/2005	7. P.
703	7	6/26/2005	T.P.
716	5	6/26/2005	T.P.

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
USPTO database search	6/26/2005	T.F
NPL on_line search	6/26/2005	T.P.
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